Application/Control No. Applicant(s)/Patent Under Reexamination 10/080,934 HILTON ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 EDWYN LABAZE 2876 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY 09-1996 US-5,553,320 Matsuura et al. 235/379 11-2002 US-6,481,620 Katou et al. 235/379 С US-6,394,346 05-2002 Bonneau et al. 235/438 D US-US-Ε US-F US-G US-Н US-1 US-J US-Κ L US-US-FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY JP 2000342837 A 12-2000 Japan SENDA, HIROKI A63F 07/02 Ν O Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W Х

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